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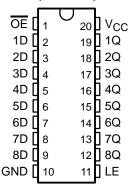
- Inputs Are TTL-Voltage Compatible
- EPIC<sup>™</sup> (Enhanced-Performance Implanted CMOS) Process
- High Latch-Up Immunity Exceeds 250 mA Per JESD 17
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

#### description

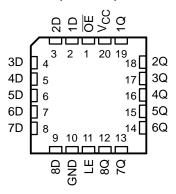
The 'AHCT573 are octal-transparent D-type latches. When the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is low, the Q outputs are latched at the logic levels of the D inputs.

A buffered output-enable  $(\overline{OE})$  input can be used to place the eight outputs in either a normal logic state (high or low) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

SN54AHCT573 . . . J OR W PACKAGE SN74AHCT573 . . . DB, DGV, DW, N, OR PW PACKAGE (TOP VIEW)



# SN54AHCT573 . . . FK PACKAGE (TOP VIEW)



OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54AHCT573 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74AHCT573 is characterized for operation from –40°C to 85°C.

# FUNCTION TABLE (each latch)

	INPUTS		OUTPUT
OE	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q <sub>0</sub>
н	X	Χ	Z



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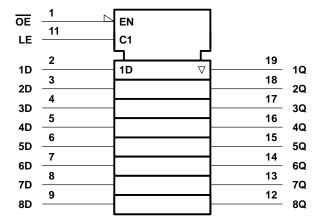
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### **SN54AHCT573, SN74AHCT573 OCTAL TRANSPARENT D-TYPE LATCHES** WITH 3-STATE OUTPUTS

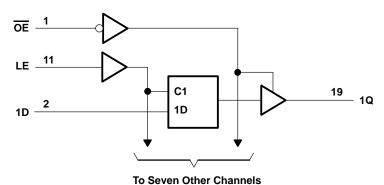
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#### logic symbol<sup>†</sup>



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V <sub>CC</sub>		0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)		0.5 V to 7 V
Output voltage range, VO (see Note 1)		$0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, $I_{IK}(V_I < 0)$		
Output clamp current, IOK (VO < 0 or VO > VCO	c)	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$		
Continuous current through V <sub>CC</sub> or GND		±75 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2):	: DB package	115°C/W
	DGV package	146°C/W
	DW package	97°C/W
	N package	67°C/W
	PW package	128°C/W
Storage temperature range, T <sub>stg</sub>		–65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### recommended operating conditions (see Note 3)

		SN54AHCT573		SN74AHCT573		UNIT
		MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2	7	2		V
VIL	Low-level input voltage		0.8		0.8	V
٧ <sub>I</sub>	Input voltage	0	5.5	0	5.5	V
Vo	Output voltage	0	VCC	0	VCC	V
ІОН	High-level output current	27/	-8		-8	mA
loL	Low-level output current	<sub>2</sub> 0/	8		8	mA
Δt/Δν	Input transition rise or fall rate	Q	20		20	ns/V
T <sub>A</sub>	Operating free-air temperature	<del>-</del> 55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	T,	\ = 25°C	;	SN54AH	ICT573	SN74AH	CT573	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
Vou	I <sub>OH</sub> = -50 μA	4.5 V	4.4	4.5		4.4		4.4		V
VOH	I <sub>OH</sub> = -8 mA	7 4.5 V	3.94			3.8		3.8		٧
V <sub>OL</sub>	I <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1		0.1	V
	I <sub>OL</sub> = 8 mA	7 4.5 V			0.36		0.44		0.44	] '
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.25		±2.5		±2.5	μΑ
lį	$V_I = V_{CC}$ or GND	5.5 V			±0.1	<i>\( \frac{1}{2} \)</i>	±1		±1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4	372	40		40	μΑ
ΔI <sub>CC</sub> †	One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.5 V			1.35	PRO,	1.5		1.5	mA
C <sub>i</sub>	$V_I = V_{CC}$ or GND	5 V		2.5	10				10	pF
Co	$V_O = V_{CC}$ or GND	5 V		3						pF

<sup>†</sup> This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

# timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		T <sub>A</sub> = 25°C		T <sub>A</sub> = 25°C SN54AHCT5		T <sub>A</sub> = 25°C SN54AHCT573 SN74AHCT573		CT573	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
t <sub>W</sub>	Pulse duration, LE high	5		5	N. W	5		ns	
t <sub>su</sub>	Setup time, data before LE↓	3.5		3.5		3.5		ns	
th	Hold time, data after LE↓	1.5		1,5		1.5		ns	

### SN54AHCT573, SN74AHCT573 OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

					SN5	4AHCT	573			
PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T,	չ = 25°C	;	MIN	MAX	UNIT	
	( 01)	(SSTI ST)		MIN	TYP	MAX	IVIIIV	IVIAA		
tPLH*	D	Q	C <sub>L</sub> = 15 pF		4.2	6	1	6.5	ns	
tpHL*	В	y	OL = 13 pr		5.1	7	1	9	115	
<sup>t</sup> PLH*	LE	Q	C <sub>L</sub> = 15 pF		4.7	6.5	1	7.5	ns	
tPHL*	LL	ά	OL = 13 pr		5.6	7.5	1	9	115	
<sup>t</sup> PZH*	<u>OE</u>	Q	C <sub>L</sub> = 15 pF		4.1	6.5	1	7	ns	
tPZL*	OE	Q	OL = 13 pi		5.5	7.5	N <sub>3</sub> 1	10	115	
tPHZ*	ŌĒ	Q	C <sub>I</sub> = 15 pF		5.5	8	1	11	ns	
tPLZ*	OE	y	OL = 15 pr		5.4	8	1	9.5	115	
t <sub>PLH</sub>	D	Q	C <sub>L</sub> = 50 pF		5.2	<u>(</u> ) 7	1	7.5	ns	
t <sub>PHL</sub>	D	3	OL = 30 pi		6.1	8	1	10	115	
<sup>t</sup> PLH	LE	Q	C <sub>L</sub> = 50 pF		5.7	7.5	1	8.5	ns	
<sup>t</sup> PHL	LL	ά	OL = 30 pr		6.6	8.5	1	10	115	
<sup>t</sup> PZH	<u>OE</u>	Q	C <sub>L</sub> = 50 pF		5.1	7.5	1	8	ns	
<sup>t</sup> PZL	OE	Q	Q	OL = 30 pr		6.5	8.5	1	11	115
<sup>t</sup> PHZ	<u>OE</u>	Q	C <sub>L</sub> = 50 pF		6.7	9	1	12	ns	
<sup>t</sup> PLZ	OE	3	OL = 30 pr		6.4	9	1	10.5	115	

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is ensured but not production tested.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

					SN7	4AHCT	573							
PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T/	λ = 25°C	;	MIN	MAX	UNIT					
	( 51)	(3311 31)	07417101174102	MIN	TYP	MAX	IVIIIV	IVIAA						
<sup>t</sup> PLH	D	Q	C <sub>L</sub> = 15 pF		4.2	6	1	6.5	ns					
t <sub>PHL</sub>	В	ά	OL = 13 pr		5.1	7	1	9	115					
tPLH	LE	Q	C <sub>L</sub> = 15 pF		4.7	6.5	1	7.5	ns					
<sup>t</sup> PHL	LL	3	OL = 13 pi		5.6	7.5	1	9	113					
<sup>t</sup> PZH	<del>OE</del>	Q	C <sub>L</sub> = 15 pF		4.1	6.5	1	7	ns					
t <sub>PZL</sub>	OE	γ	Ų.	Q	ď	<u> </u>		GL = 13 pr		5.5	7.5	1	10	113
<sup>t</sup> PHZ	ŌĒ	Ð	C <sub>L</sub> = 15 pF		5.5	8	1	11	ns					
tPLZ	OE	3	OL = 13 pi	ο <u>Γ</u> = 10 βι		5.4	8	1	9.5	113				
tPLH	D	Q	C <sub>L</sub> = 50 pF		5.2	7	1	7.5	ns					
<sup>t</sup> PHL	В	ά	OL = 30 pr		6.1	8	1	10	115					
t <sub>PLH</sub>	LE	Q	C <sub>L</sub> = 50 pF		5.7	7.5	1	8.5	ns					
t <sub>PHL</sub>		3	OL = 30 pi		6.6	8.5	1	10	113					
<sup>t</sup> PZH	<del>OE</del>	Q	C <sub>L</sub> = 50 pF		5.1	7.5	1	8	ns					
<sup>t</sup> PZL	OE	3	OL = 30 bi		6.5	8.5	1	11	113					
<sup>t</sup> PHZ	<del>OE</del>	Q	C <sub>L</sub> = 50 pF		6.7	9	1	12	ns					
<sup>t</sup> PLZ	UE	۷	OL - 30 Pi		6.4	9	1	10.5	113					

## SN54AHCT573, SN74AHCT573 OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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## output-skew characteristics, C<sub>L</sub> = 50 pF (see Note 4)

			SN74Al	HCT573		
PARAMETER		VCC	T <sub>A</sub> = 25°C	MIN	MAX	UNIT
			MIN MAX	IVIIIV	WIAA	
t <sub>sk(o)</sub>	Output skew	$5~V\pm0.5~V$	1		1	ns

NOTE 4: Characteristics are determined during product characterization and ensured by design.

## noise characteristics, $V_{CC}$ = 5 V, $C_L$ = 50 pF, $T_A$ = 25°C (see Note 5)

	PARAMETER	SN74AH	CT573	UNIT
	PARAMETER		MAX	UNIT
VIH(D)	High-level dynamic input voltage	2		V
V <sub>IL(D)</sub>	Low-level dynamic input voltage		0.8	V

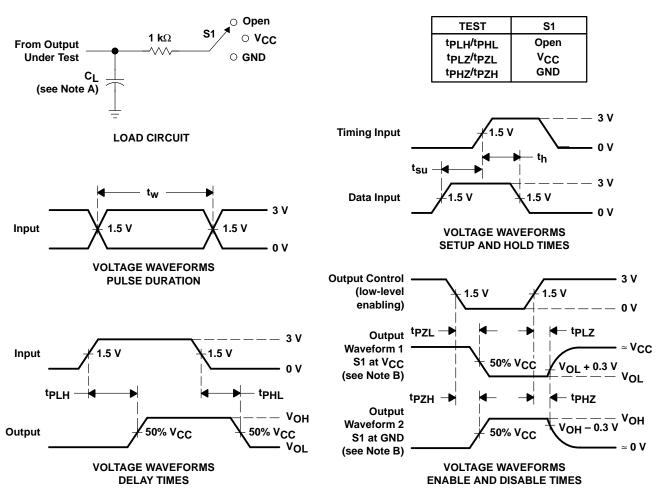
NOTE 5: Characteristics are determined during product characterization and ensured by design for surface-mount packages only.

## operating characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

	PARAMETER		ONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	No load,	f = 1 MHz	16	pF

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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f = 3$  ns.  $t_f = 3$  ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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